SIEMENS

Data sheet

6AU1432-2AA00-0AA0

SIMOTION Drive-based Controller Extension CX32-2; inverter
control module; to increase drive count on SIMOTION D4x5-2;
interfaces: 6 DI, 4 DI/DO, 4 DRIVE-CLiQ

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Product brand name	SIMOTION
Product type designation	CX32-2
Version of the motion control system	Controller Extension

Integrated drive control

Maximum number of axes for integrated drive control	
• servo	6
• vector	6
• V/f	12
• note	Alternative control modes; drive control based on SINAMICS S120 CU320-2, firmware version V4.x

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Communication

Interfaces

DRIVE-CLiQ

General technical data	
Fan	No fan
DC supply voltage	
• rated value	24 V
• minimum	20.4 V
• maximum	28.8 V
Consumed current / typical	300 mA
• Note	with no load on inputs/outputs, no 24 V supply via DRIVE-CLiQ interface
Making current, typ.	1.6 A
Power loss [W] / typical	7 W
Ambient temperature, during	
long-term storage	-25 +55 °C
• transport	-40 +70 °C
operation	0 55 °C
— note	Maximum installation altitude 4000 m (13124 ft) above sea level. Above an altitude of 2000 m (6562 ft), the maximum ambient temperature decreases by 7 °C (12.6 °F) per 1000 m (3281 ft).
Relative humidity	
during operation	5 95 %

 without condensation, tested acc. to IEC 60068-2-38 	Wert fehlt
Air pressure	620 1 060 hPa
Degree of protection	IP20
Height	380 mm
Width	25 mm
Depth	270 mm
• Note	When the spacer is removed 230 mm (9.05 in) deep
Net weight	2 600 g
Digital inputs	
Number of digital inputs	6
DC input voltage	
● rated value	24 V
● for signal "1"	15 30 V
• for signal "0"	-3 +5 V
Electrical isolation	Yes
• note	Yes, in groups of 6
Current consumption for "1" signal level, typ.	3.5 mA
Input delay time for	
• signal "0" → "1", typ.	50 μs
• signal "1" → "0", typ.	150 µs
Digital inputs/outputs	
Number of digital I/Os	4
	parameterizable as DI, as DO, as probe input (max. 4)
Number of digital I/Os	
Number of digital I/Os Parameterization possibility of the digital I/Os	
Number of digital I/Os Parameterization possibility of the digital I/Os If used as an input	
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No
500 mA
2 mA
150 µs
400 µs
75 μs
100 μs
Data for Vcc = 24 V; load 48 Ohm; "1" = 90 % VOut, "0" = 10 % VOut
4 kHz
2 Hz
11 Hz
Yes

Additional technical data		
Back-up of non-volatile data		
of retentive data	unlimited buffer duration	
Approvals		
• USA	cULus	
● Canada	cULus	
Australia	RCM (formerly C-Tick)	
• Korea	KCC	
 Russia, Belarus and Kazakhstan 	EAC	